

**Vishay Siliconix** 

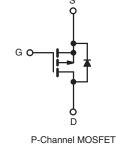
RoHS

COMPLIANT

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	- 100			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V 1.2			
Q <sub>g</sub> (Max.) (nC)	8.7			
Q <sub>gs</sub> (nC)	2.2			
Q <sub>gd</sub> (nC)	4.1			
Configuration	Single			





#### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION		
Package	HVMDIP	
Lead (Pb)-free	IRFD9110PbF	
	SiHFD9110-E3	
SnPb	IRFD9110	
	SiHFD9110	

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub>	= 25 °C, unless otherwis	se noted)			
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	- 100	v	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current	$V_{GS}$ at - 10 V $T_A = 25 \degree C$	1	- 0.70		
Continuous Drain Current	$V_{GS}$ at - 10 V $T_A = 25 °C$ $T_A = 100 °C$	ID	- 0.49	А	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	- 5.6			
Linear Derating Factor		0.0083	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	140	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	- 0.7	А	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	0.13	mJ	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	PD	1.3	W	
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	- 5.5	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175		
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>	- °C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = -25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 52 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = -2.0 \text{ A}$  (see fig. 12).

c.  $I_{SD} \leq$  - 4.0 A, dl/dt  $\leq$  75 A/µs,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq$  175 °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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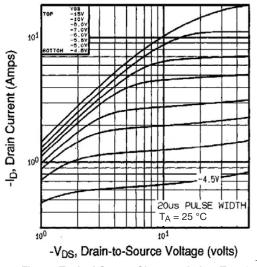
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		120			°C/W	
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, u	nless otherw	ise noted)						
PARAMETER	SYMBOL	TES		DNS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = - 2	250 μA	- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I <sub>D</sub>	= - 1 mA	-	- 0.091	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-	$V_{GS}, I_D = -2$		- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20$ \		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =	- 100 V, V <sub>G</sub>	<sub>S</sub> = 0 V	-	-	- 100	μA
Zero date voltage Brain ourient	'D88	V <sub>DS</sub> = - 80 V	V, V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 150 °C	-	-	- 500	μ, τ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = - 10 V	I <sub>D</sub> =	- 0.42 A <sup>b</sup>	-	-	1.2	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =	- 50 V, I <sub>D</sub> = -	0.42 A	0.60	-	-	S
Dynamic								
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V,$		-	200	-	
Output Capacitance	Coss		V <sub>DS</sub> = - 25 V,		-	94	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see	0 MHz, see fig. 5		18	-	
Total Gate Charge	Qg		$I_{\rm D} = -4.0 \text{ A}, V_{\rm DS} = -80 \text{ V}$ see fig. 6 and 13 <sup>b</sup> -		-	-	8.7	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V			-	2.2	nC	
Gate-Drain Charge	Q <sub>gd</sub>				-	-	4.1	1
Turn-On Delay Time	t <sub>d(on)</sub>		50.14.1		-	10	-	
Rise Time	t <sub>r</sub>				-	27	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$		15	-	- ns		
Fall Time	t <sub>f</sub>			17	-			
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact - 4.0 - 4.0 - 6.0		-	- nH			
Internal Source Inductance	L <sub>S</sub>			6.0	-			
Drain-Source Body Diode Characteristic	S							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the			-	-	- 0.70	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	- 5.6		
Body Diode Voltage	$V_{SD}$	$T_{J} = 25 \ ^{\circ}C, \ I_{S} = - \ 0.7 \ A, \ V_{GS} = 0 \ V^{b}$		-	-	- 5.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 4.0 A, dl/dt = 100 A/μs <sup>b</sup>		-	82	160	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.15	0.30	μC	

#### Notes

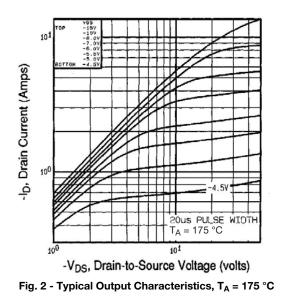
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

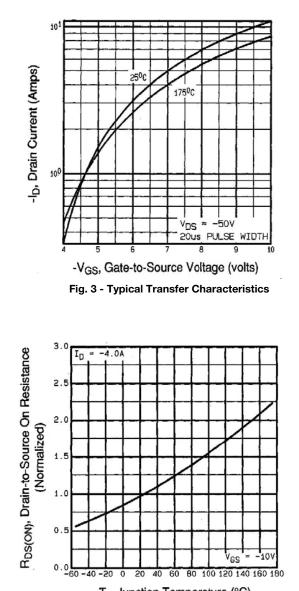












T<sub>J</sub>, Junction Temperature (°C) Fig. 4 - Normalized On-Resistance vs. Temperature



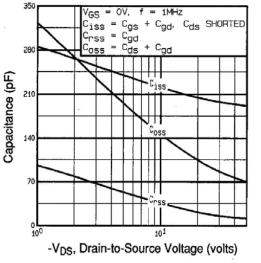
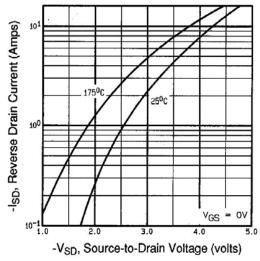


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





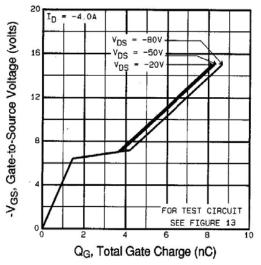
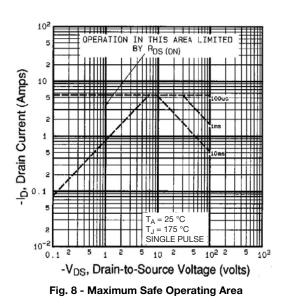


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





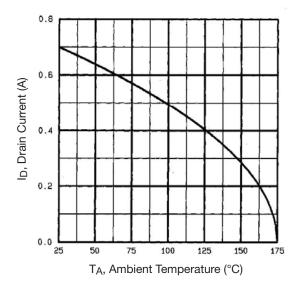


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

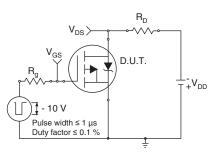


Fig. 10a - Switching Time Test Circuit

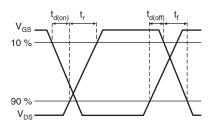


Fig. 10b - Switching Time Waveforms

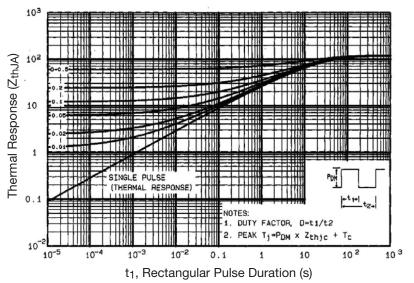


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



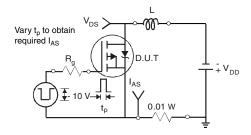


Fig. 12a - Unclamped Inductive Test Circuit

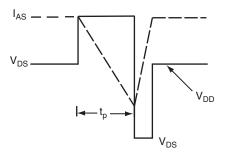


Fig. 12b - Unclamped Inductive Waveforms

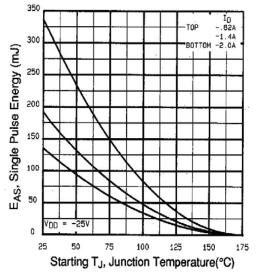


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

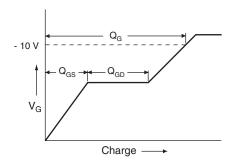


Fig. 13a - Basic Gate Charge Waveform

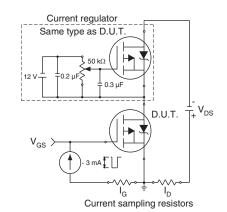
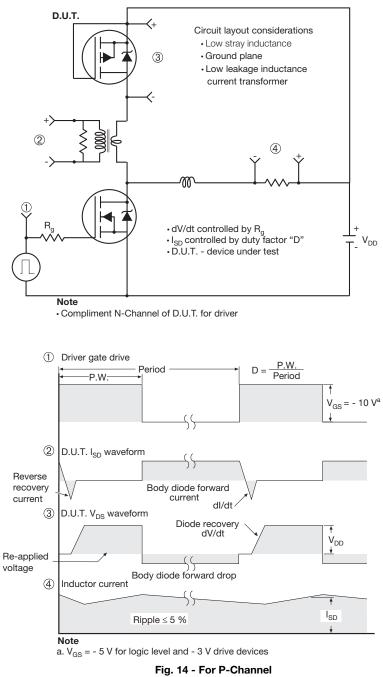


Fig. 13b - Gate Charge Test Circuit



#### **Vishay Siliconix**





Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?91138">www.vishay.com/ppg?91138</a>.



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#### HVM DIP (High voltage)





	INCHES		MILLIN	IETERS
DIM.	MIN.	MAX.	MIN.	MAX.
А	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10			

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



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